Applicant(s)/Patent Under Application/Control No. Reexamination 10/757,714 PETTEY ET AL. **Notice of References Cited** Examiner Art Unit Page 1 of 1 2661 Brian D Nguyen

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|---|-----------------|-----------------|----------------|
| | Α | US-6,665,304 | 12-2003 | Beck et al. | 370/401 |
| İ | В | US-2004/0117536 | 06-2004 | Franke et al. | 710/302 |
| | С | US-2004/0081104 | 04-2004 | Pan et al. | 370/254 |
| | D | US-2004/0088414 | 05-2004 | Flynn et al. | 709/226 |
| | E | US-2004/0098532 | 05-2004 | Huang et al. | 710/316 |
| | F | US-2004/0111559 | 06-2004 | Heil, Thomas | 711/114 |
| | G | US-2004/0117598 | 06-2004 | Arimilli et al. | 712/030 |
| | Н | US-2004/0073712 | 04-2004 | Larson et al. | 709/249 |
| | ı | US- | | | |
| | J | US- | | | |
| | к | US- | | | |
| | L | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
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NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
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A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.